

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Application Serial No. . . . . 09/825,087  
Filing Date . . . . . April 2, 2001  
Inventor . . . . . Cem Basceri et al  
Assignee . . . . . Micron Technology, Inc.  
Group Art Unit . . . . . 2822  
Examiner . . . . . M. Guerrero  
Attorney's Docket No. . . . . MI22-1483  
Title: Mixed Composition Interface Layer and Method of Forming

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TC 1700

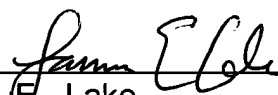
**INFORMATION DISCLOSURE STATEMENT**

References – See Attached Form PTO-1449

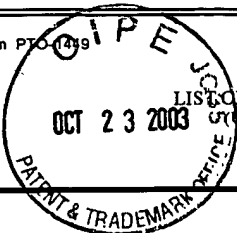
The attached form PTO-1449 is submitted in compliance with 37 CFR §1.56. No admission is made regarding whether any of the submitted references is prior art. Copies of the references are attached.

Respectfully submitted,

Dated: 23 Oct 2003

Attorney:   
James E. Lake  
Reg. No. 44,854

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| Form PTO-1419   |    | U.S. DEPARTMENT OF COMMERCE<br>PATENT AND TRADEMARK OFFICE |   | ATTY. DOCKET NO.<br>M122-1483 |       | SERIAL NO.<br>09/825,087 |                               |
| <br>LIST OF ART CITED BY APPLICANT<br>(Use several sheets if necessary)   |    |  |   | APPLICANT<br>Cem Basceri      |       |                          |                               |
|   |    |  |   | FILING DATE<br>April 2, 2001  |       | GROUP<br>1762            |                               |
| U.S. PATENT DOCUMENTS   |    |  |   |                               |       |                          |                               |
| *Examiner<br>Initial  |    | Document<br>Number   | Date  | Name                          | Class | Subclass                 | Filing Date<br>If Appropriate |
|   | AA |  |   |                               |       |                          |                               |
|   | AB |  |   |                               |       |                          |                               |
|   | AC |  |   |                               |       |                          |                               |
|   | AD |  |   |                               |       |                          |                               |
|   | AE |  |   |                               |       |                          |                               |
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|   | AJ |  |   |                               |       |                          |                               |
|   | AK |  |   |                               |       |                          |                               |
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| FOREIGN PATENT DOCUMENTS  |    |  |   |                               |       |                          |                               |
|   |    | Document<br>Number   | Date  | Country                       | Class | Subclass                 | Translation                   |
|   |    |  |   |                               |       |                          | Yes      No                   |
|   | AM |  |   |                               |       |                          |                               |
|   | AN |  |   |                               |       |                          |                               |
|   | AO |  |   |                               |       |                          |                               |
|   | AP |  |   |                               |       |                          |                               |
|   | AQ |  |   |                               |       |                          |                               |
| OTHER REFERENCES (including Author, Title, Date, Pertinent Pages, Etc.)   |    |  |   |                               |       |                          |                               |
|   | AR | c  | Suntola, "Atomic Layer Epitaxy", Handbook of Crystal Growth, Vol. 3, Chapter 14, pps. 602-663.  |                               |       |                          |                               |
|   | AS | c  | Suntola, "Surface Chemistry of Materials Deposition at Atomic Layer Level", Applied Surface Science, vol. 100/101, March 1996, pp. 391-398. |                               |       |                          |                               |
| EXAMINER  |    |  |   | DATE CONSIDERED               |       |                          |                               |
| *EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant. |    |  |   |                               |       |                          |                               |